

MH51208ANA-85L,-10L,-12L,-15L/ MH51208ANA-85H,-10H,-12H,-15H

4194304-BIT(524288-WORD BY 8-BIT)CMOS STATIC RAM

MITSUBISHI (MEMORY/ASIC)

DESCRIPTION

The MH51208ANA is a 4194304 bits CMOS static RAM module organized as 524288-words by 8-bits. It consists of four industry standard 128K×8 static RAMs (M5M51008VP/RV) and one decoder.

The stand-by current is low enough for a battery back-up application. It is mounted a TSOP package.

FEATURES

Type	Access time (max)	Power supply current	
		Active (max)	Stand by (max)
MH51208ANA-85L MH51208ANA-10L MH51208ANA-12L MH51208ANA-15L	85ns 100ns 120ns 150ns	110mA	400 μ A
MH51208ANA-85H MH51208ANA-10H MH51208ANA-12H MH51208ANA-15H	85ns 100ns 120ns 150ns		80 μ A

- Single +5V Power Supply
- No Clocks, No Refresh
- Data-Hold on +2V Power Supply
- Three-State Outputs: OR-tie Capability
- Simple Memory Expansion by \bar{S}
- \bar{OE} Prevents Data Contention in the I/O Bus
- Common Data I/O

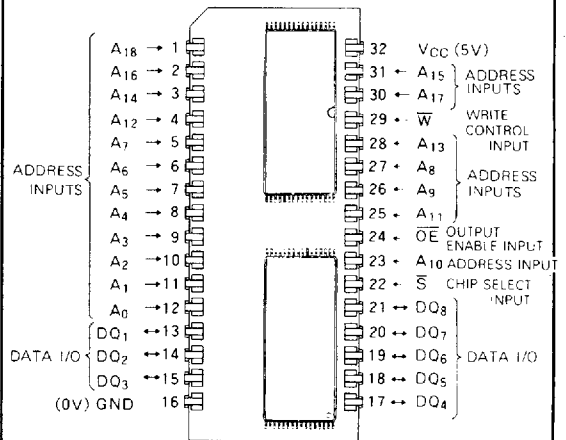
APPLICATION

Small Capacity Memory Units.

FUNCTION

The operation mode of the MH51208ANA is determined by a combination of the device control inputs \bar{S} , \bar{W} and \bar{OE} . Each mode is summarized in the function table. (see next page)

PIN CONFIGURATION (TOP VIEW)



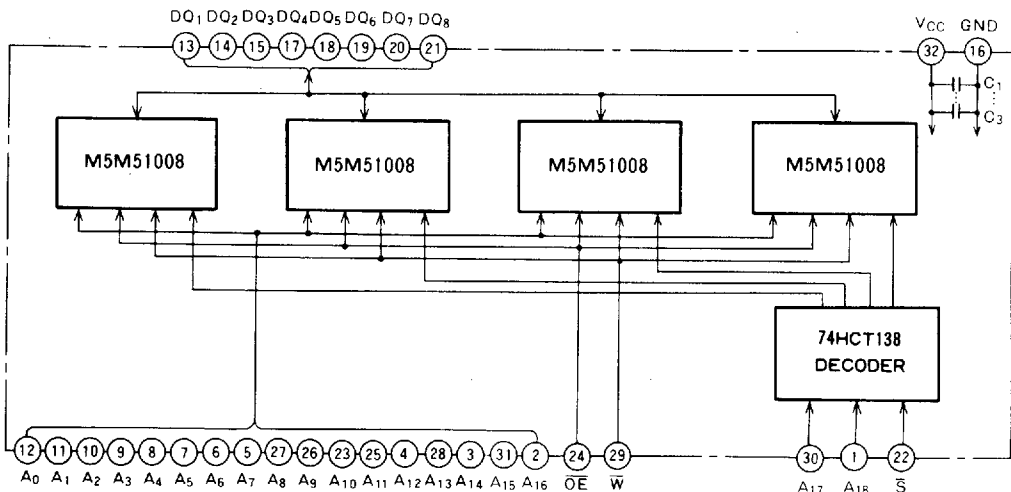
Outline 32N1D

A write cycle is executed whenever the low level \bar{W} overlaps with the low level \bar{S} . The address must be set up before the write cycle and must be stable during the entire cycle. The data is latched into a cell on the trailing edge of \bar{W} , \bar{S} , whichever occurs first, requiring the set-up and hold time relative to these edge to be maintained. The output enable \bar{OE} directly controls the output stage. Setting the \bar{OE} at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated.

A read cycle is executed by setting \bar{W} at a high level and \bar{OE} at a low level while \bar{S} are in an active state.

When setting \bar{S} at a high level, the chip is in a non-

BLOCK DIAGRAM



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selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by \bar{S} . The power supply current is reduced as low as the stand-by current which is specified as I_{CC3} or I_{CC4} , and the memory data can be held +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

\bar{S}	\bar{W}	\bar{OE}	Mode	DQ	I_{CC}
H	X	X	Non selection	High-impedance	Standby
L	L	X	Write	D_{IN}	Active
L	H	L	Read	D_{OUT}	Active
L	H	H		High-impedance	Active

RECOMMENDED OPERATING CONDITIONS ($T_a = 0 \sim 70^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min	Typ	Max	
V_{CC}	Supply voltage	4.5	5	5.5	V
GND	Supply voltage		0		V
V_{IL}	Low input voltage	-0.3		0.8	V
V_{IH}	High input voltage	3.2		$V_{CC}+0.3$	V

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
V_{CC}	Supply voltage	With respect to GND	-0.3 ~ 7	V
V_I	Input voltage		-0.3 ~ $V_{CC}+0.3$	V
V_O	Output voltage		0 ~ V_{CC}	V
P_d	Power dissipation	$T_a = 25^\circ\text{C}$	700	mW
T_{opr}	Operating temperature		0 ~ 70	$^\circ\text{C}$
T_{stg}	Storage temperature		-40 ~ 100	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a = 0 \sim 70^\circ\text{C}$, $V_{CC} = 5V \pm 10\%$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
V_{IH}	High input voltage		3.2		$V_{CC}+0.3$	V
V_{IL}	Low input voltage		-0.3		0.8	V
V_{OH}	High output voltage	$I_{OH} = -1\text{mA}$	2.4			V
V_{OL}	Low output voltage	$I_{OL} = 2\text{mA}$			0.4	V
I_I	Input current	$V_I = 0 \sim V_{CC}$			± 4	μA
I_O	Output current	$\bar{S} = V_{IH}$ or $\bar{OE} = V_{IH}$ $V_{I/O} = 0 \sim V_{CC}$			± 4	μA
I_{CC1}	Active supply current (AC, MOS level)	$\bar{S} < 0.2$, $\bar{W} > V_{CC}-0.3$ output open other input < 0.2 or $> V_{CC}-0.3$ Min. cycle		65	100	mA
I_{CC2}	Active supply current (AC, TTL level)	$\bar{S} = V_{IL}$, $\bar{W} = V_{IH}$ output open other input $= V_{IL}$ or V_{IH} Min. cycle		75	110	mA
I_{CC3}	Stand-by supply current	$\bar{S} \geq V_{CC}-0.2V$ A17, A18 ≥ 0.2 or $\geq V_{CC}-0.2$ Other inputs $= 0 \sim V_{CC}$	ANA-L		400	μA
			ANA-H		80	μA
I_{CC4}	Stand-by supply current	$\bar{S} = V_{IH}$, Other inputs $= 0 \sim V_{CC}$			24	mA
C_I	Input capacitance ($T_a = 25^\circ\text{C}$)	$V_I = \text{GND}$, $V_I = 25\text{mVrms}$, $f = 1\text{MHz}$			30	pF
C_O	Output capacitance ($T_a = 25^\circ\text{C}$)	$V_O = \text{GND}$, $V_O = 25\text{mVrms}$, $f = 1\text{MHz}$			30	pF

Note 1 Direction for current flowing into IC is indicated as positive (no mark)
2. Typical value is $V_{CC} = 5V$, $T_a = 25^\circ\text{C}$



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SWITCHING CHARACTERISTICS ($T_a=0\sim 70^\circ\text{C}$, $V_{CC}=5V\pm 10\%$, unless otherwise noted)

Read cycle

Symbol	Parameter	Limits												Unit
		MH51208ANA-85			MH51208ANA-10			MH51208ANA-12			MH51208ANA-15			
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
t_{CR}	Read cycle time	85			100			120			150			ns
$t_{a(A)}$	Address access time			85			100			120			150	ns
$t_{a(S)}$	Chip select access time			85			100			120			150	ns
$t_{a(OE)}$	Output enable access time			35			45			50			60	ns
$t_{dIS(S)}$	Output disable time after \bar{S} high			40			45			50			55	ns
$t_{dIS(OE)}$	Output disable time after \overline{OE} high			25			30			35			40	ns
$t_{en(S)}$	Output enable time after \bar{S} low	5			5			5			5			ns
$t_{en(OE)}$	Output enable time after \overline{OE} low	5			5			5			5			ns
$t_V(A)$	Data valid time after address change	10			10			10			10			ns

TIMING REQUIREMENTS ($T_a=0\sim 70^\circ\text{C}$, $V_{CC}=5V\pm 10\%$, unless otherwise noted)

Write cycle

Symbol	Parameter	Limits												Unit
		MH51208ANA-85			MH51208ANA-10			MH51208ANA-12			MH51208ANA-15			
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
t_{CW}	Write cycle time	85			100			120			150			ns
$t_{W(W)}$	Write pulse width	55			65			75			85			ns
$t_{su(A)}$	Address set up time	0			0			0			0			ns
$t_{su(A-\bar{W}H)}$	Address set up time with respect to \bar{W} high	65			75			85			100			ns
$t_{su(S)}$	Chip select set up time	80			90			100			115			ns
$t_{su(D)}$	Data set up time	30			35			40			45			ns
$t_h(D)$	Data hold time	0			0			0			0			ns
$t_{rec(W)}$	Write recovery time	0			0			0			0			ns
$t_{dIS(W)}$	Output disable time after \bar{W} low			25			30			35			40	ns
$t_{dIS(OE)}$	Output disable time after \overline{OE} high			25			30			35			40	ns
$t_{en(W)}$	Output enable time after \bar{W} high	5			5			5			5			ns
$t_{en(OE)}$	Output enable time after \overline{OE} low	5			5			5			5			ns

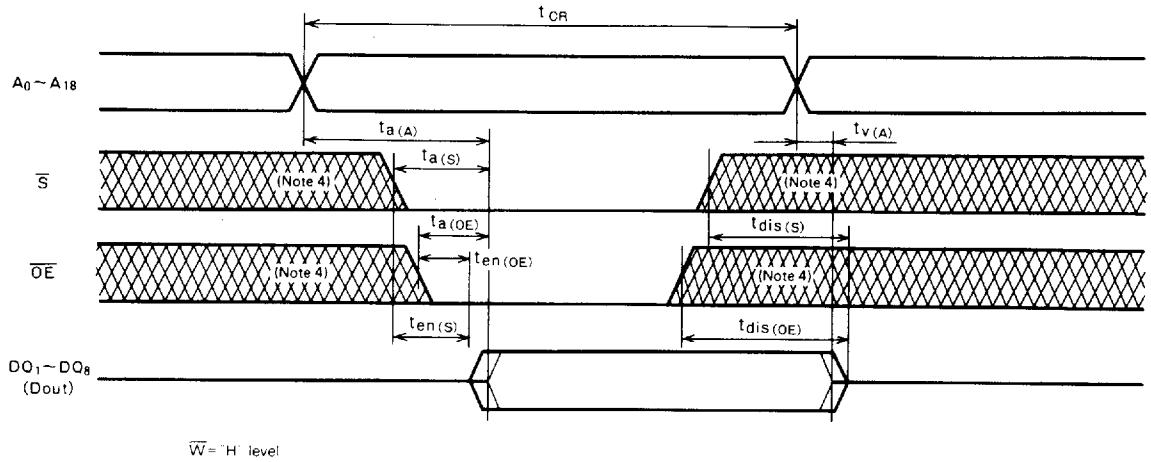
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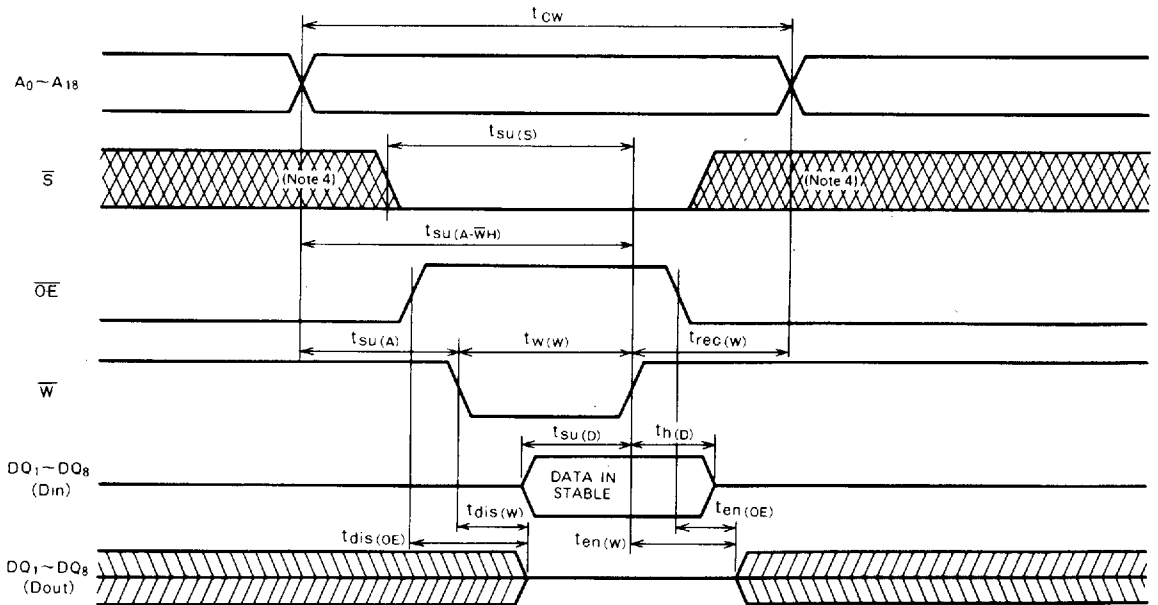
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TIMING DIAGRAM

Read cycle



Write cycle (\bar{W} control)

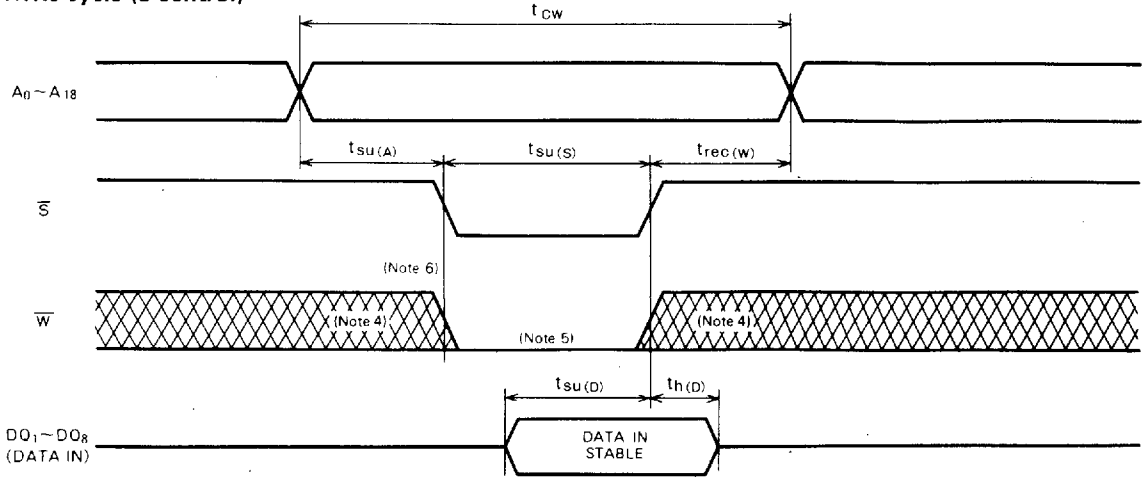


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Write cycle (\bar{S} control)



- 4 Hatching indicates the state is don't care.
- 5 Writing is executed in overlap of \bar{S} and \bar{W} low.
- 6 If \bar{W} goes low simultaneously with or prior to \bar{S} , the output remains in the high-impedance state.
- 7 Don't active inverted phase signal externally when DQ pin is in output mode.

POWER DOWN CHARACTERISTICS

ELECTRICAL CHARACTERISTICS ($T_a = 0 \sim 70^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$V_{CC(PD)}$	Power down supply voltage		2			V
$V_I(\bar{S})$	Chip select input \bar{S}	$2.2\text{V} \leq V_{CC(PD)}$	3.2			V
		$2\text{V} \leq V_{CC(PD)} \leq 2.2\text{V}$		$V_{CC(PD)}$		V
$I_{CC(PD)}$	Power down supply current	$V_{CC} = 3\text{V}$, A17, A18 < 0.2 or $> V_{CC} - 0.2$ other inputs = $0 \sim V_{CC}$			200	μA
			ANA-L		40	μA
						ANA-H

TIMING REQUIREMENTS ($T_a = 0 \sim 70^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$t_{su(PD)}$	Power down setup time		0			ns
$t_{rec(PD)}$	Power down recovery time		t_{CR}			ns

POWER DOWN CHARACTERISTICS

